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SHEET 1 OF 1

10/505450

Form PTO 1449  
(Modified)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

258096US0PCT

SERIAL NO.

New U.S. PCT Application  
Based on PCT/JP03/02308

## LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Kenichi FUJINO, et al.

FILING DATE

Herewith

GROUP

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
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## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
	AO	2001-114961	04/24/01	JP (English abstract only)		NO
	AP	11-315185	11/16/99	JP (English abstract only)		NO
	AQ	11-302324	11/02/99	JP (English abstract only)		NO
	AR	5-222320	08/31/93	JP (with English abstract)		NO
	AS	148346	07/17/85	EP		NO
	AT					
	AU					
	AV					

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
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☐ Additional References sheet(s) attached

Examiner

Date Considered

06/15/06

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 258096US0PCT		SERIAL NO. 10/505,458	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Kenichi FUJINO, et al.			
				FILING DATE April 5, 2005		GROUP 1755	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
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		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
<i>la</i>	AO	WO 03/002659 A1	01/09/2003	WIPO (with English Abstract)			X
<i>la</i>	AP	WO 90/12656	11/01/1990	WIPO			
	AQ	8-6009	01/12/1996	JAPAN (with English Abstract)			X
	AR	5-209006	08/20/1993	JAPAN (with English Abstract)			X
	AS	6-80738	03/22/1994	JAPAN (with English Abstract)			X
	AT	3045498	03/17/2000	JAPAN (with English Abstract)			X
	AU	2769958	04/17/1998	JAPAN (with English Abstract)			X
<i>la</i>	AV	2001-206914	07/31/2001	JAPAN (with English Abstract)			X
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
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						<input type="checkbox"/> Additional References sheet(s) attached	
Examiner <i>Lox Chi</i>						Date Considered <i>06/15/06</i>	

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<i>la</i>	AA US 5,539,043	07/23/96	KIMURA, et al.				
<i>la</i>	AB US 5,559,176	09/24/96	NAMBA, et al.				
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Examiner <i>La...</i>				Date Considered <i>06/14/06</i>			
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